# **IRF510S, SiHF510S**

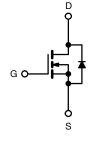
**Vishay Siliconix** 



Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	100					
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.54				
Q <sub>g</sub> max. (nC)	8.3					
Q <sub>gs</sub> (nC)	2.3					
Q <sub>gd</sub> (nC)	3.8					
Configuration	Single					





N-Channel MOSFET

## **FEATURES**

- Surface mount
- · Available in tape and reel
- Dynamic dV/dt rating
- · Repetitive avalanche rated
- 175 °C operating temperature
- Fast switching
- Ease of paralleling
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

## DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D<sup>2</sup>PAK (TO-263) is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION							
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)				
Lead (Pb)-free and Halogen-free	SiHF510S-GE3	SiHF510STRL-GE3 <sup>a</sup>	SiHF510STRR-GE3 <sup>a</sup>				
Lood (Ph) free	IRF510SPbF	IRF510STRLPbF <sup>a</sup>	IRF510STRRPbF <sup>a</sup>				
Lead (Pb)-free	SiHF510S-E3	SiHF510STL-E3 <sup>a</sup>	SiHF510STR-E3 <sup>a</sup>				

Note a. See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS (T</b> C	= 25 °C, unless otherwise	se noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	100	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	v		
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$	- I <sub>D</sub>	5.6		
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 100 \text{ °C}$		4.0	А	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	20			
Linear Derating Factor		0.29	W/°C		
Linear Derating Factor (PCB mount) <sup>e</sup>		0.025	VV/ C		
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	75	mJ	
Avalanche Current <sup>a</sup>		I <sub>AR</sub>	5.6	А	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	4.3	mJ	
Maximum Power Dissipation	Maximum Power Dissipation $T_{\rm C} = 25 ^{\circ}{\rm C}$			w	
Maximum Power Dissipation (PCB mount) e	T <sub>A</sub> = 25 °C	PD	3.7	v	
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	5.5	V/ns		
Operating Junction and Storage Temperature Rang	je	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Soldering Recommendations (Peak temperature) <sup>d</sup>	for 10 s	Ŭ	300		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 4.8 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 5.6 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 5.6 \text{ A}$ , dl/dt  $\leq 75 \text{ A/µs}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 175 \text{ °C}$ .

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

S15-2693-Rev. D, 16-Nov-15

Document Number: 91016

RoHS HALOGEN FREE



Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Maximum Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	$V_{GS} = 0, I_D = 250 \ \mu A$			-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	-	0.12	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	,	$V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	-	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	25 250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 3.4 A <sup>b</sup>	-	-	0.54	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 3.4 A <sup>b</sup>	1.3	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	180	-	
Output Capacitance	Coss		$V_{DS} = 25 V,$	-	81	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	.0 MHz, see fig. 5	-	15	-	
Total Gate Charge	Qg			-	-	8.3	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and fig. 13 <sup>b</sup>	-	-	2.3	nC
Gate-Drain Charge	Q <sub>gd</sub>		see lig. o and lig. 15	-	-	3.8	
Turn-On Delay Time	t <sub>d(on)</sub>		•	-	6.9	-	- ns
Rise Time	tr	V <sub>DD</sub> =	= 50 V, I <sub>D</sub> = 5.6 A,	-	16	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 24 \Omega$ ,	$R_D = 8.4 \Omega$ , see fig. 10 <sup>b</sup>	-	15	-	
Fall Time	t <sub>f</sub>			-	9.4	-	
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25") f	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	- nH
Internal Source Inductance	L <sub>S</sub>	1 0			7.5	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	MOSFET symbol showing the integral reverse p - n junction diode		-	5.6	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				-	20	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	, $I_{\rm S}$ = 5.6 A, $V_{\rm GS}$ = 0 V <sup>b</sup>	-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T _ 05 °C	- 5 6 A dl/dt 100 A/b	-	100	200	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_{\rm J} = 25  {}^{\circ} \rm C, I_{\rm F}$	= 5.6 A, dl/dt = 100 A/µs <sup>b</sup>	-	0.44	0.88	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	-on is dor	ninated b	v Ls and	Ln)

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

# IRF510S, SiHF510S



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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

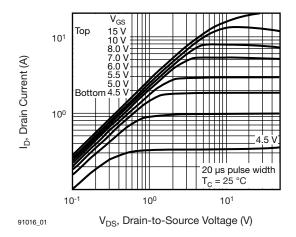


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

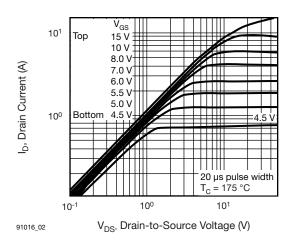


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 175 °C

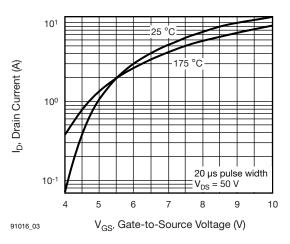


Fig. 3 - Typical Transfer Characteristics

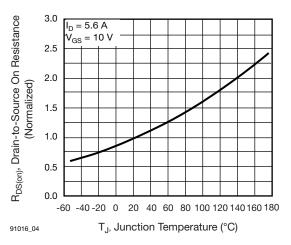


Fig. 4 - Normalized On-Resistance vs. Temperature

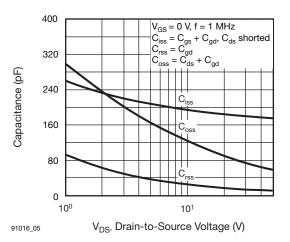


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

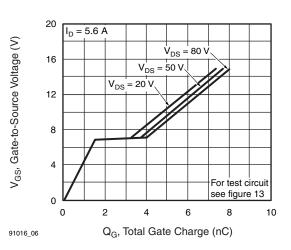


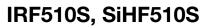
Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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3 cal questions\_contact: hym@vish Document Number: 91016

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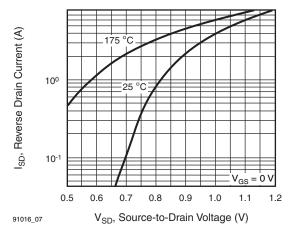


Fig. 7 - Typical Source-Drain Diode Forward Voltage

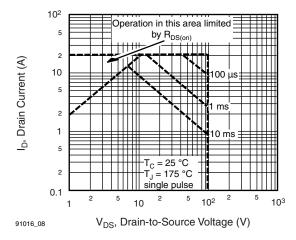


Fig. 8 - Maximum Safe Operating Area

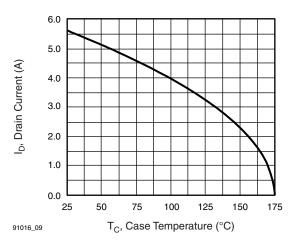


Fig. 9 - Maximum Drain Current vs. Case Temperature

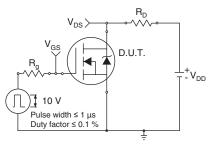


Fig. 10a - Switching Time Test Circuit

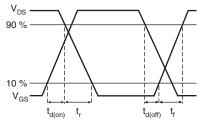
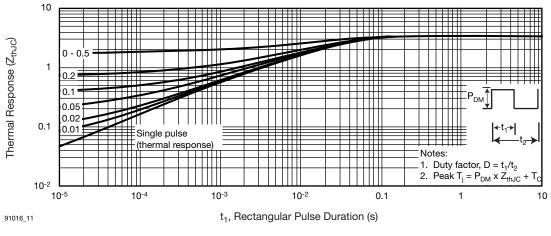


Fig. 10b - Switching Time Waveforms





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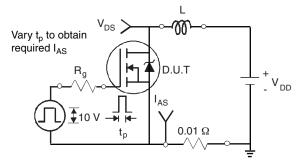


Fig. 12a - Unclamped Inductive Test Circuit

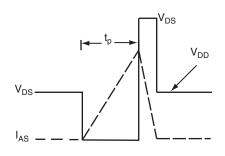


Fig. 12b - Unclamped Inductive Waveforms

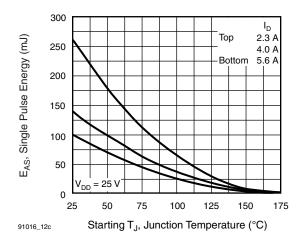


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

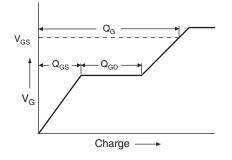


Fig. 13a - Basic Gate Charge Waveform

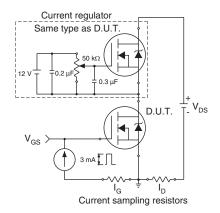


Fig. 13b - Gate Charge Test Circuit

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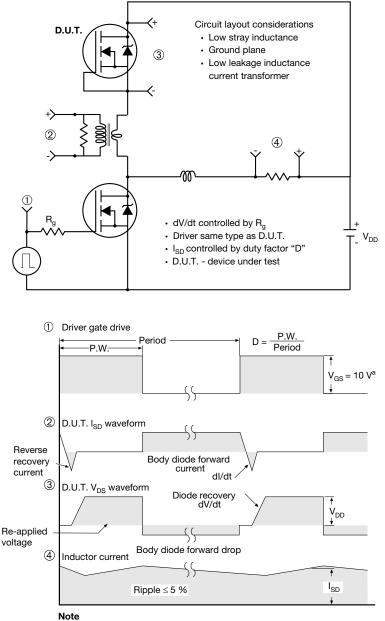
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# IRF510S, SiHF510S





## Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5$  V for logic level devices

## Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?91016">www.vishay.com/ppg?91016</a>.

H

A1

B

Gauge plane

L3

Detail "A" Rotated 90° CW scale 8:1

0° to 8° **Vishay Siliconix** 

Seating plane

## **TO-263AB (HIGH VOLTAGE)**

∕3 ⁄4 A

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Detail A

(Datum A)

D

 $\underline{4}$ 11

	2	-	Y 2 x b2 2 x b ⊕ 0.010 @ A(	■ ating 5 b1, b b1, b b1, b c) c) c) c) c) c) c) c) c) c)	$\begin{array}{c} c_{1} \\ c_{1} \\ c_{2} \\ c_{3} \\ c_{4} \\ c_{5} \\ c_{5} \\ c_{7} \\$	<b>a</b> - 1		Ū.	1 <u>4</u>		
	MILLIN	IETERS	INCHES				MILLIN	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.		DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.06	4.83	0.160	0.190		D1	6.86	-	0.270	-	
				0.010		F		10.07	0.000	0.420	
A1	0.00	0.25	0.000	0.010		E	9.65	10.67	0.380	0.120	
A1 b	0.00 0.51	0.25 0.99	0.000	0.010		E1	9.65 6.22	- 10.67	0.380	-	
							6.22	- 10.67 - BSC	0.245	- BSC	
b	0.51	0.99	0.020	0.039		E1	6.22	-	0.245	-	
b b1	0.51 0.51	0.99 0.89	0.020 0.020	0.039 0.035		E1 e	6.22 2.54	- BSC	0.245	- ) BSC	
b b1 b2	0.51 0.51 1.14	0.99 0.89 1.78	0.020 0.020 0.045	0.039 0.035 0.070		E1 e H	6.22 2.54 14.61	- BSC 15.88	0.245 0.100 0.575	- ) BSC 0.625	
b b1 b2 b3	0.51 0.51 1.14 1.14	0.99 0.89 1.78 1.73	0.020 0.020 0.045 0.045	0.039 0.035 0.070 0.068		E1 e H L	6.22 2.54 14.61 1.78	- BSC 15.88 2.79	0.245 0.100 0.575 0.070	- 0 BSC 0.625 0.110	
b b1 b2 b3 c	0.51 0.51 1.14 1.14 0.38	0.99 0.89 1.78 1.73 0.74	0.020 0.020 0.045 0.045 0.015	0.039 0.035 0.070 0.068 0.029		E1 e H L L1	6.22 2.54 14.61 1.78 - -	- BSC 15.88 2.79 1.65	0.245 0.100 0.575 0.070 - -	- 0 BSC 0.625 0.110 0.066	
b b1 b2 b3 c c1	0.51 0.51 1.14 1.14 0.38 0.38	0.99 0.89 1.78 1.73 0.74 0.58	0.020 0.020 0.045 0.045 0.015 0.015	0.039 0.035 0.070 0.068 0.029 0.023		E1 e H L L1 L2	6.22 2.54 14.61 1.78 - -	- BSC 15.88 2.79 1.65 1.78	0.245 0.100 0.575 0.070 - -	- 0 BSC 0.625 0.110 0.066 0.070	

Α

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

5. Dimension b1 and c1 apply to base metal only.

6. Datum A and B to be determined at datum plane H.

7. Outline conforms to JEDEC outline to TO-263AB.



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